

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/082,794	BAU ET AL.	
Examiner	Art Unit	
J. Derek Rutten	2192	

SEARCHED					
Class	Subclass	Date	Examiner		

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST (US-PGPUB; USPAT; EPO; JPO; IBM_TDB; DERWENT) - see search history printout	8/21/2007	JDR		
EAST (US-PGPUB; USPAT; EPO; JPO; IBM_TDB; DERWENT) - see search history printout	8/23/2007	JDR		
Tuan Dam and Pat Salce (consulted re. double patenting)	8/31/2007	JDR		